

Notice of References Cited	Application/Control No. 09/802,464		Applicant(s)/Patent Under Reexamination BAWOLEK ET AL.	
	Examiner José R Díaz		Art Unit 2815	Page 1 of 1

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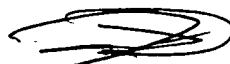
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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

FORM PTO-892		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		SERIAL NO. 09/524,081	GROUP ART UNIT 2815	ATTACHMENT TO PAPER NO.	 09/802461 U.S. PAT. & TM. OFF.
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